National Semiconductor

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74VHC32
Quad 2-Input OR Gate

General Description

The VHC32 is an advanced high speed CMOS 2-Input OR Gate fabricated with silicon gate CMOS technology. It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

The internal circuit is composed of 4 stages including buffer output, which provide high noise immunity and stable output. An input protection circuit ensures that 0V to 7V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5V to 3V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

Features

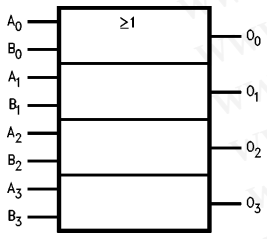
- Low Power Dissipation: I_{CC} = 2 μA (Max) at T_A = 25°C
- High Noise Immunity: V_{NIH} = V_{NIL} = 28% V_{CC} (Min)
- All inputs are equipped with a Power Down Protection Function
- Balanced Propagation Delays: $t_{PLH} \cong t_{PHL}$
- Low Noise: V_{OLP} = 0.8V (Max)
- Pin and Function Compatible with 74HC32

Commercial	Package Number	Package Description
74VHC32M	M14A	14-Lead Molded JEDEC SOIC
74VHC32SJ	M14D	14-Lead Molded EIAJ SOIC
74VHC32MSC	MSC14	14-Lead Molded EIAJ Type 1 SSOP
74VHC32MTC	MTC14	14-Lead Molded JEDEC Type 1 TSSOP
74VHC32N	N14A	14-Lead Molded DIP

Note: Surface mount packages are also available on Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.
EIAJ Type I SSOP available Tape and Reel only, order MSCX.

Logic Symbol

IEEE/IEC



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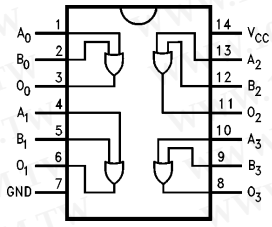
Connection Diagram

Pin Assignment for DIP, SSOP, TSSOP and SOIC



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Pin Names	Description
A_n, B_n	Inputs
O_n	Outputs

Truth Table

A	B	O
H	H	H
L	H	H
H	L	H
L	L	L

RRD-B30M125/Printed in U. S. A.

Absolute Maximum Ratings (Note 1)

Supply Voltage (V_{CC})	−0.5V to +7.0V
DC Input Voltage (V_{IN})	−0.5V to +7.0V
DC Output Voltage (V_{OUT})	−0.5V to V_{CC} + 0.5V
Input Diode Current (I_{IK})	−20 mA
Output Diode Current (I_{OK})	±20 mA
DC Output Current (I_{OUT})	±25 mA
DC V_{CC}/GND Current (I_{CC})	±50 mA
Storage Temperature (T_{STG})	−65°C to +150°C
Lead Temperature (T_L) (Soldering, 10 seconds)	260°C

Note 1: *Absolute Maximum Ratings are values beyond which the device may be damaged or have its useful life impaired. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation outside databook specifications.*

Recommended Operating Conditions

Supply Voltage (V_{CC})	2.0V to +5.5V
Input Voltage (V_{IN})	0V to +5.5V
Output Voltage (V_{OUT})	0V to V_{CC}
Operating Temperature (T_{OPR})	−40°C to +85°C
Input Rise and Fall Time (t_r, t_f)	
V_{CC} = 3.3V ±0.3V	0 ~ 100 ns/V
V_{CC} = 5.0V ±0.5V	0 ~ 20 ns/V

DC Characteristics for 'VHC Family Devices

Symbol	Parameter	V_{CC} (V)	74VHC T_A = 25°C			74VHC T_A = −40°C to +85°C		Units	Conditions	
			Min	Typ	Max	Min	Max			
V_{IH}	High Level Input Voltage	2.0 3.0–5.5	1.50 0.7 V_{CC}			1.50 0.7 V_{CC}		V		
V_{IL}	Low Level Input Voltage	2.0 3.0–5.5			0.50 0.3 V_{CC}		0.50 0.3 V_{CC}	V		
V_{OH}	High Level Output Voltage	2.0 3.0 4.5	1.9 2.9 4.4	2.0 3.0 4.5		1.9 2.9 4.4		V	V_{IN} = V_{IH} or V_{IL}	I_{OH} = −50 μA
		3.0 4.5	2.58 3.94			2.48 3.80		V		I_{OH} = −4 mA I_{OH} = −8 mA
V_{OL}	Low Level Output Voltage	2.0 3.0 4.5		0.0 0.0 0.0	0.1 0.1 0.1		0.1 0.1 0.1	V	V_{IN} = V_{IH} or V_{IL}	I_{OL} = 50 μA
		3.0 4.5			0.36 0.36		0.44 0.44	V		I_{OL} = 4 mA I_{OL} = 8 mA
I_{IN}	Input Leakage Current	0–5.5			±0.1		±1.0	μA	V_{IN} = 5.5V or GND	
I_{CC}	Quiescent Supply Current	5.5			2.0		20.0	μA	V_{IN} = V_{CC} or GND	

DC Characteristics for 'VHC Family Devices

Symbol	Parameter	V_{CC} (V)	74VHC $T_A = 25°C$ Typ	74VHC $T_A = 25°C$ Limit	Units	Conditions
**V_{OLP}	Quiet Output Maximum Dynamic V_{OL}	5.0	0.3	0.8	V	$C_L = 50$ pF
**V_{OLV}	Quiet Output Minimum Dynamic V_{OL}	5.0	−0.3	−0.8	V	$C_L = 50$ pF
**V_{IHD}	Minimum High Level Dynamic Input Voltage	5.0		3.5	V	$C_L = 50$ pF
**V_{ILD}	Maximum Low Level Dynamic Input Voltage	5.0		1.5	V	$C_L = 50$ pF

**Parameter guaranteed by design.

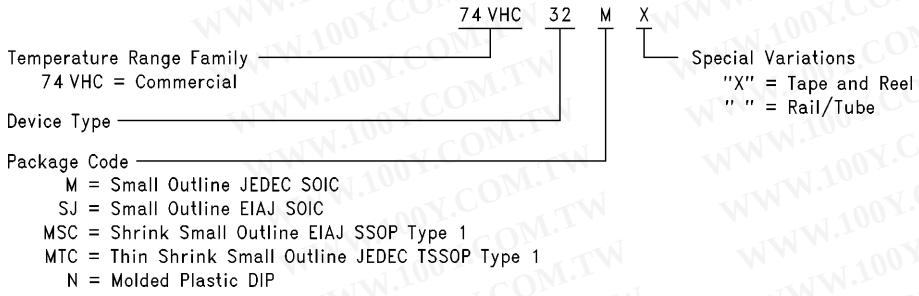
AC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	74VHC $T_A = 25°C$ Min	Typ	Max	74VHC $T_A = -40°C$ to $+85°C$ Min	Max	Units	Test Condition
t_{PHL}, t_{PLH}	Propagation Delay	3.3 ±0.3		5.5	7.9	1.0	9.5	ns	$C_L = 15$ pF
				8.0	11.4	1.0	13.0		$C_L = 50$ pF
		5.0 ±0.5		3.8	5.5	1.0	6.5	ns	$C_L = 15$ pF
				5.3	7.5	1.0	8.5		$C_L = 50$ pF
C_{IN}	Input Capacitance			4	10		10	pF	V_{CC} = Open
C_{PD}	Power Dissipation Capacitance			14				pF	(Note 1)

Note 1: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation: I_{CC} (opr.) = C_{PD} * V_{CC} * f_{IN} + $I_{CC}/4$ (per gate).

Ordering Information

The device number is used to form part of a simplified purchasing code, where the package type and temperature range are defined as follows:



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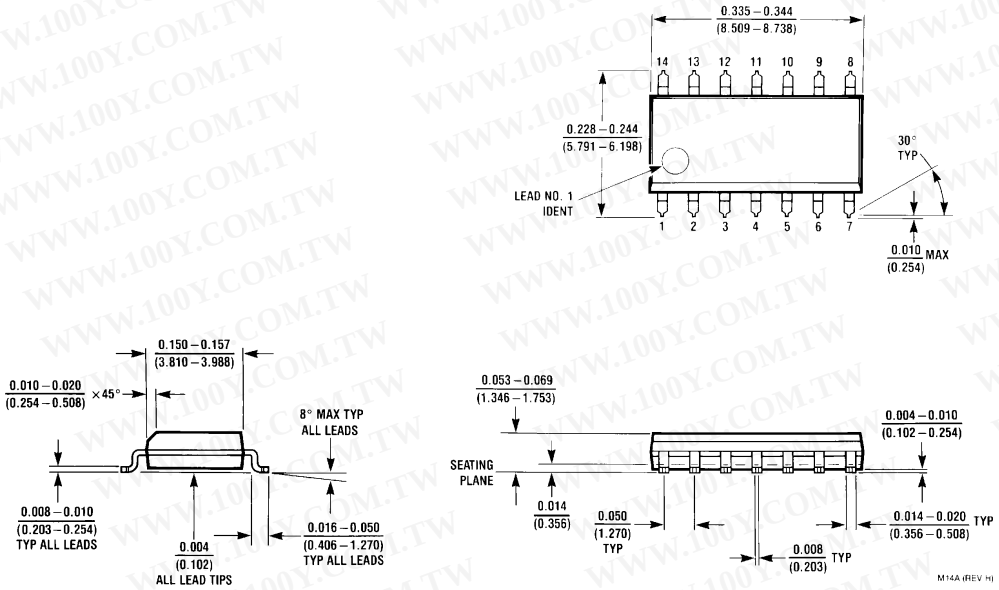
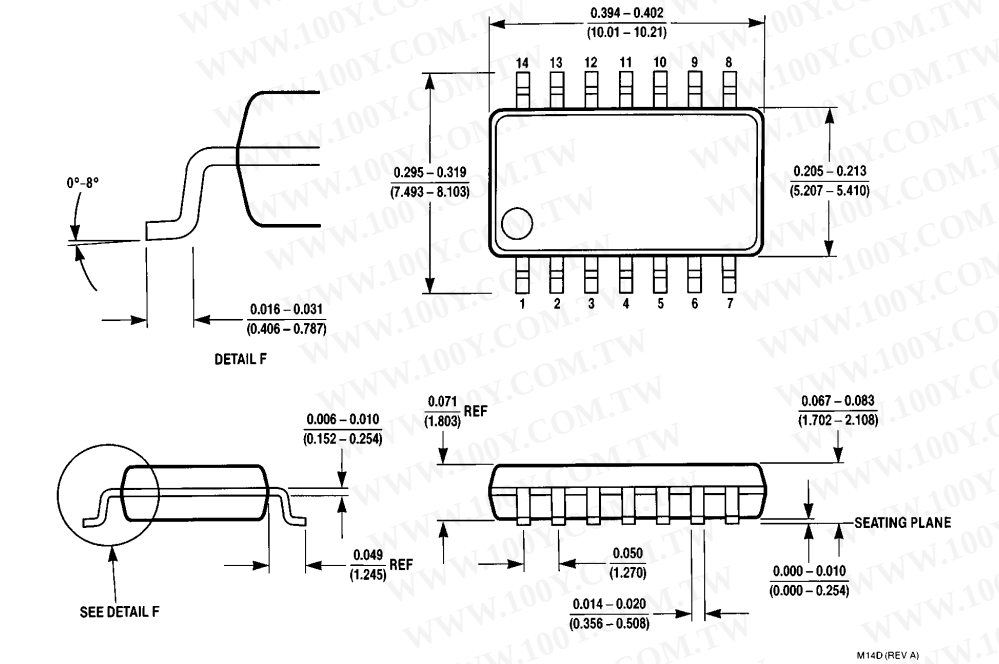
Physical Dimensions inches (millimeters)

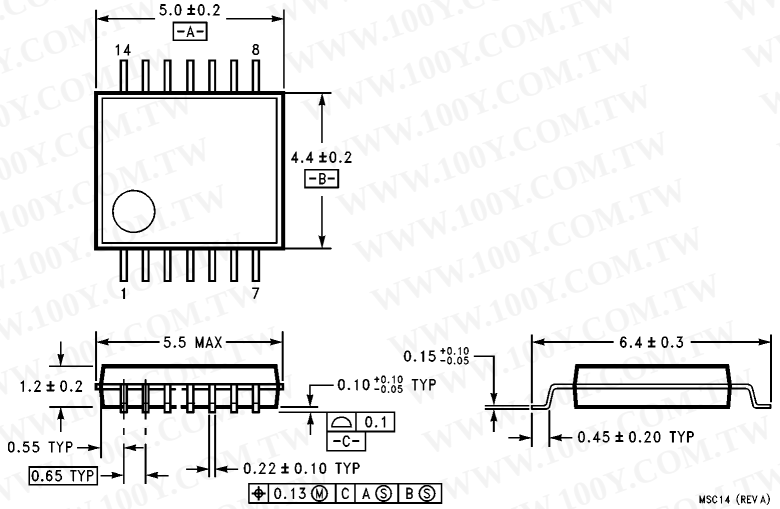


14-Lead Small Outline Integrated Circuit–JEDEC (M)
NS Package Number M14A

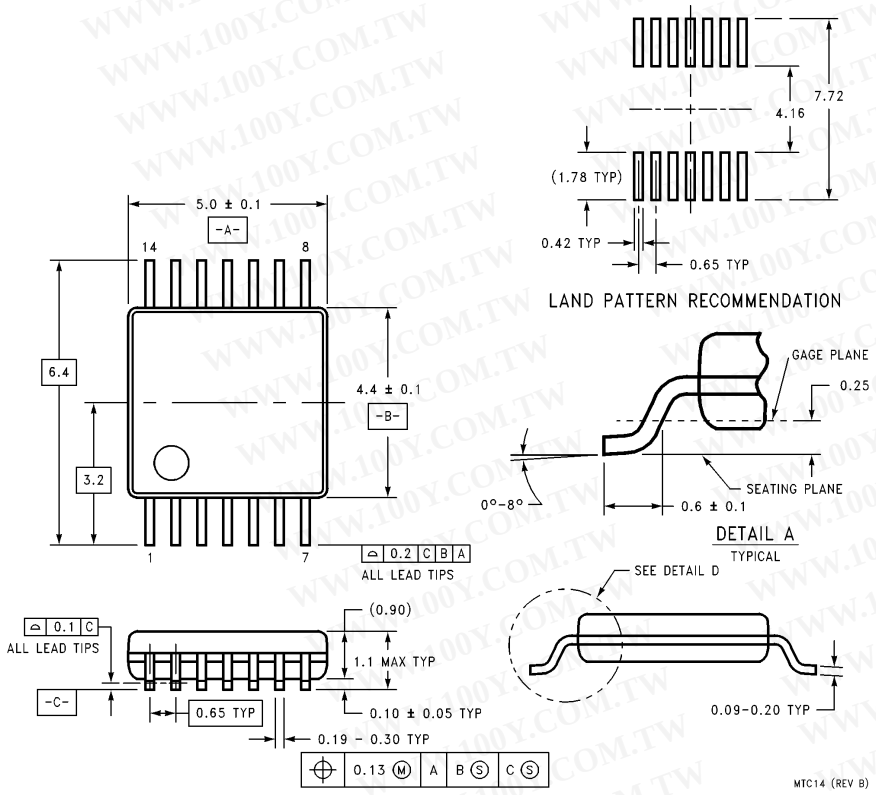


14-Lead Plastic EIAJ SOIC (SJ)
NS Package Number M14D

Physical Dimensions inches (millimeters) (Continued)

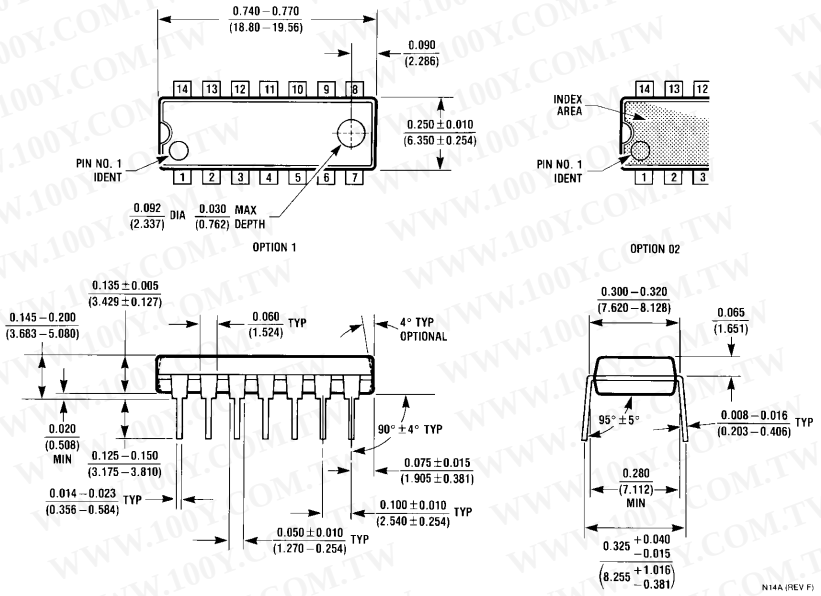


14-Lead Plastic EIAJ SSOP Type 1 (MSC)
NS Package Number MSC14



14-Lead Plastic JEDEC TSOP Type I (MTC)
NS Package Number MTC14

Physical Dimensions inches (millimeters) (Continued)



14-Lead Molded Dual-In-Line Package (MDIP)
NS Package Number N14A

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National Semiconductor Corporation
1111 West Bardin Road
Arlington, TX 76017
Tel: 1(800) 272-9959
Fax: 1(800) 737-7018

National Semiconductor Europe
Fax: (+49) 0-180-530 85 86
Email: cnjwge@tevm2.nsc.com
Deutsch Tel: (+49) 0-180-530 85 85
English Tel: (+49) 0-180-532 78 32
Français Tel: (+49) 0-180-532 93 58
Italiano Tel: (+49) 0-180-534 16 80

National Semiconductor Hong Kong Ltd.
13th Floor, Straight Block,
Ocean Centre, 5 Canton Rd.
Tsimshatsui, Kowloon
Hong Kong
Tel: (852) 2737-1600
Fax: (852) 2736-9960

National Semiconductor Japan Ltd.
Tel: 81-043-299-2309
Fax: 81-043-299-2408